

# Sysid Course VT1 2016 An Overview.



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## An Introductory Example

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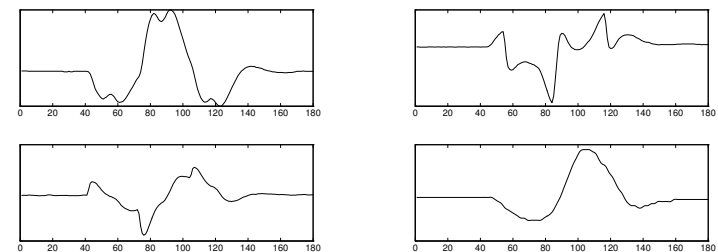
## Outline

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- An Umbrella Contribution for the Material in the Course
- The classic, conventional System Identification Setup
- The Identification Loop
- Model and Model Structures
- Identification Methods
- Model Validation
- → xyz means: details are given on page xyz in the textbook Ljung: System Identification. Theory for the User, 2nd Edition, Prentice-Hall 1999.

## Data from Gripen

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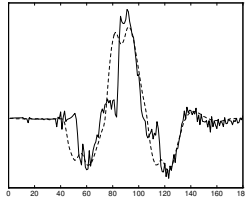
Pitch rate, Canard,  
Elevator, Leading Edge Flap

- How do the control surface angles affect the pitch rate?
- Aerodynamical derivatives?
- How to use the information in flight data?

$y(t)$  pitch rate at time  $t$ .  $u_1(t)$  canard angle at time  $t$ .  $T = 1/60$ .

Try

$$y(t) = +b_1u_1(t - T) + b_2u_1(t - 2T) + b_3u_1(t - 3T) + b_4u_1(t - 4T)$$

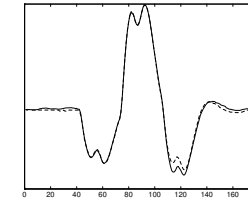


Dashed line: Actual Pitch rate. Solid line: 10 step ahead predicted pitch rate, based on the fourth order model from canard angle only.



$u_1$  canard angle;  $u_2$  Elevator angle;  $u_3$  Leading edge flap;

$$y(t) = -a_1y(t - T) - a_2y(t - 2T) - a_3y(t - 3T) - a_4y(t - 4T) \\ + b_1^1u_1(t - T) + \dots + b_1^4u_1(t - 4T) \\ + b_2^1u_2(t - T) + \dots + b_1^3u_3(t - T) + \dots + b_4^3u_3(t - 4T)$$



- Select a class of candidate models
- Select a member in this class using the observed data
- Evaluate the quality of the obtained model
- Design the experiment so that the model will be “good”.



### A Typical Problem

Given Observed Input-Output Data: Find a Description of the System that Generated the Data [Simulator or Predictor. Linear System: Impulse response or Bode plot].

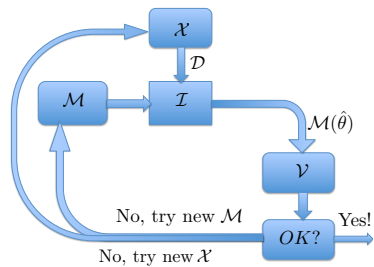
### Basic Approach

Find a suitable Model Structure, Estimate its parameters, and compute the response of the resulting model

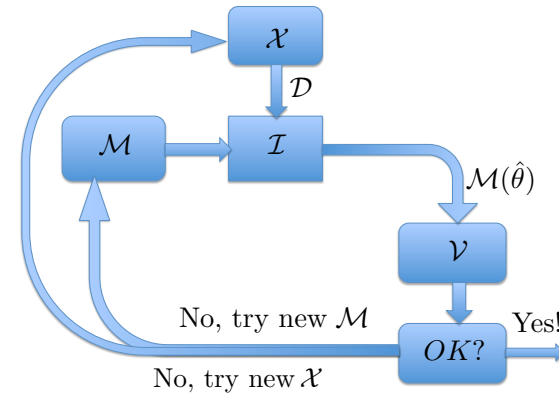
### Techniques

Estimate the parameters by ML techniques/PEM (prediction error methods). Find the model structure by AIC, BIC or Cross Validation





$\mathcal{X}$ : The Experiment  
 $\mathcal{D}$ : The Measured Data  
 $\mathcal{M}$ : The Model Set  
 $\mathcal{I}$ : The Identification Method  
 $\mathcal{V}$ : The Validation Procedure



- A model is a mathematical expression that describes the connections between measured inputs and outputs, and possibly related noise sequences.
- They can come in many different forms
- The models are labeled with a parameter vector  $\theta$
- A common framework is to describe the model as a predictor of the next output, based on observations of past input-output data.

Observed input-output ( $u, y$ ) data up to time  $t$ :  $Z^t$

Model described by predictor:  $\mathcal{M}(\theta) : \hat{y}(t|\theta) = g(t, \theta, Z^{t-1})$ .

General Description

$$y(t) = G(q, \theta)u(t) + H(q, \theta)e(t), \quad q : \text{shift op.} \quad e : \text{white noise}$$

$$G(q, \theta)u(t) = \sum_{k=1}^{\infty} g_k u(t-k), \quad H(q, \theta)e(t) = 1 + \sum_{k=1}^{\infty} h_k e(t-k)$$

$$y(t) = G(q, \theta)u(t) + v(t); \quad \text{Spectrum } \Phi_v(\omega) = \lambda |H(e^{i\omega})|^2$$

Predictor

$$\hat{y}(t|\theta) = G(q, \theta)u(t) + [I - H^{-1}(q, \theta)][y(t) - G(q, \theta)u(t)]$$

## BJ (Box-Jenkins)

$$G(q, \theta) = \frac{B(q)}{F(q)}; \quad H(q, \theta) = \frac{C(q)}{D(q)}$$

$$B(q) = b_1q^{-1} + b_2q^{-2} + \dots + b_{nb}q^{-nb}$$

$$F(q) = 1 + f_1q^{-1} + \dots + f_{nf}q^{-nf}$$

$$\theta = [b_1, b_2, \dots, f_{nf}]$$

## ARX:

$$y(t) = \frac{B(q)}{A(q)}u(t) + \frac{1}{A(q)}e(t) \text{ or}$$

$$A(q)y(t) = B(q)u(t) + e(t) \text{ or}$$

$$y(t) + a_1y(t-1) + \dots + a_nay(t-na)$$

$$= b_1u(t-1) + \dots + b_nbu(t-nb)$$

## The ARX Model is a Linear Regression

The predictor for ARX can be written

$$\hat{y}(t|\theta) = \varphi^T(t)\theta$$

$$\varphi(t) = [-y(t-1) \quad \dots \quad -y(t-na) \quad u(t-1) \quad \dots \quad u(t-nb)]^T$$

$$\theta = [a_1 \quad \dots \quad a_{na} \quad b_1 \quad \dots \quad b_{nb}]^T$$

## State-Space with Possibly Physically Parameterized Matrices

$$x(t+1) = A(\theta)x(t) + B(\theta)u(t) + K(\theta)e(t)$$

$$y(t) = C(\theta)x(t) + e(t)$$

Corresponds to

$$G(q, \theta) = C(\theta)(qI - A(\theta))^{-1}B(\theta).$$

$$H(q, \theta) = C(\theta)(qI - A(\theta))^{-1}K(\theta) + I$$

## Physical Model with unknown parameters

$$\dot{x}(t) = \mathcal{F}(\theta)x(t) + \mathcal{G}(\theta)u(t) + w(t)$$

$$y(t) = C(\theta)x(t) + D(\theta)u(t) + v(t)$$

Sample it (with correct Input Intersample Behaviour):

$$x(t+1) = A(\theta)x(t) + B(\theta)u(t) + K(\theta)e(t)$$

$$y(t) = C(\theta)x(t) + e(t)$$

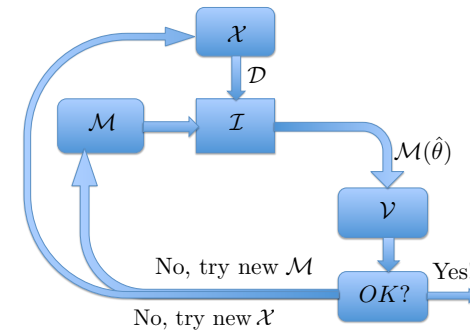
Now apply the discrete time formalism to this model, which is parameterized in terms of the CT parameters  $\theta$

$\mathcal{M}(\theta) : \hat{y}(t|\theta) = g(t, \theta, Z^{t-1})$ .  $g$  non-linear in  $Z$ .

- More in the NL lecture notes
- Physical Grey-Box Models**  
Perform physical modeling (e.g. in MODELICA) and denote unknown physical parameters by  $\theta$ . Collect the model equations as

$$\begin{aligned} \dot{x}(t) &= f(x(t), u(t), \theta) \\ y(t) &= h(x(t), u(t), \theta) \end{aligned}$$

- NLARX models**
- Block Oriented Models**, Wiener-Hammerstein and similar
- Local Linear Models, Linear Parameter Varying Models.**  
Linear model  $G(z, p)$  parameterized by a measured regime variable  $p$



If a model,  $\hat{y}(t|\theta)$ , essentially is a predictor of the next output, is is natural to evaluate its quality by assessing how well it predicts: [Form the Prediction error and measure its size:](#)

$$\varepsilon(t, \theta) = y(t) - \hat{y}(t|\theta), \quad \ell(\varepsilon(t, \theta))$$

(Note: Linear system  $\varepsilon = \frac{1}{H}(y - Gu)$ ) Typically  $\ell(x) = x^2$ . How has it performed historically?

$$V_N(\theta) = \sum_{t=1}^N \ell(\varepsilon(t, \theta))$$

Which model in the structure performed best?

$$\hat{\theta}_N = \arg \min_{\theta \in D_{\mathcal{M}}} V_N(\theta)$$

Maximum Likelihood (ML): Which model makes the recorded observations most likely? (pdf: probability density function)

$$\max p(Y^N | \theta) \quad p : \text{the pdf of the outputs for a given parameter value}$$

If the innovations  $e$  of the measured data have the pdf  $f(x)$ , then

$$-\log p(Y^N | \theta) = V_N(\theta) = \sum_{t=1}^N \ell(\varepsilon(t, \theta)) \quad \ell(x) = -\log f(x)$$

So, what minimizes the "pragmatic fit" is also the ML estimate!

Gaussian pdf  $\Rightarrow \ell(x) \sim x^2$

More in the Special Issues Lecture notes

Regularization: To curb the flexibility of the model structure and to provide better numerics in the minimization we can postulate a regularized criterion:

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$$W_N(\theta) = V_N(\theta) + \lambda(\theta - \theta^+)^T R((\theta - \theta^+))$$

Bayesian View: The parameter vector  $\theta$  is a random vector with a certain prior pdf, and we seek the posterior pdf, given the observations. Suppose the prior is  $\theta \in N(\theta^+, R^{-1}/\lambda)$

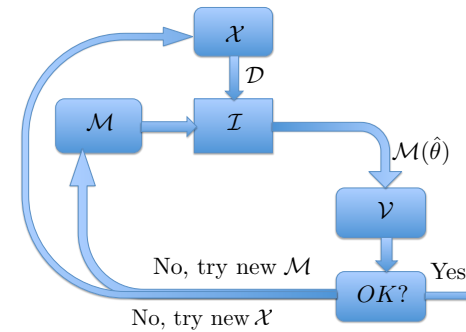
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As the number of data,  $N$ , tends to infinity

- $\hat{\theta}_N \rightarrow \theta^* \sim \arg \min_{\theta} E\ell(\varepsilon(t, \theta))$  the best possible predictor in  $\mathcal{M}$
- If  $\mathcal{M}$  contains a true description of the system
  - Cov  $\hat{\theta}_N = \frac{\lambda}{N} [E\psi(t)\psi^T(t)]^{-1} [\psi(t) = \frac{d}{d\theta} \hat{y}(t|\theta), \lambda : \text{noise level}] \dots$
  - ... is the Cramér-Rao lower bound for any (unbiased) estimator.

E: Expectation. These are very nice optimal properties:

- The model structure is large enough: The ML/PEM estimated model is (asymptotically) the best possible one. Has smallest possible variance (Cramér- Rao)
- The model structure is not large enough: The ML/PEM estimate converges to the best possible approximation of the system. "The estimate has smallest possible asymptotic bias."

We illustrate the main ideas for a simple curve-fitting problem:

System:  $y(t) = g_0(x_t) + e(t)$ ,  $e$  white noise. Model:  $g(x_t, \theta)$

Convergence: (LLN= Law of Large Numbers)

$$\begin{aligned} V_N(\theta) &= \frac{1}{N} \sum (g_0(x_t) + e(t) - g(x_t, \theta))^2 \\ &= \frac{1}{N} \sum (g_0(x_t) - g(x_t, \theta))^2 + \frac{1}{N} \sum e^2(t) \\ &\quad + \frac{2}{N} \sum (g_0(x_t) - g(x_t, \theta))e(t) \end{aligned}$$

$$\text{LLN: } \frac{1}{N} \sum (g_0(x_t) - g(x_t, \theta))e(t) \rightarrow 0 \quad (\text{uniformly in } \theta!)$$

$$\begin{aligned} \text{so } V_N(\theta) &\rightarrow \bar{E}(g_0(x_t) - g(x_t, \theta))^2 \\ &= \lim \frac{1}{N} \sum (g_0(x_t) - g(x_t, \theta))^2 \text{ as } N \rightarrow \infty \end{aligned}$$

Asymptotic Distribution (CLT= Central Limit Theorem)

$$0 = V'_N(\hat{\theta}_N) = V'_N(\theta^*) + V''_N(\theta^*)(\hat{\theta}_N - \theta^*)$$

$$(\hat{\theta}_N - \theta^*) = -[V''_N(\theta^*)]^{-1}V'_N(\theta^*)$$

$$V'_N(\theta) = \frac{2}{N} \sum (y(t) - g(x_t, \theta))g'(x_t, \theta)$$

$$V'_N(\theta^*) = \frac{2}{N} \sum e(t)\psi(t); \quad \psi(t) = g'(x_t; \theta^*)$$

$$\text{LLN: } V''_N(\theta^*) = \frac{2}{N} \sum \psi(t)\psi^T(t) + \frac{2}{N} \sum e(t)g''(x_t, \theta^*) \rightarrow 2\bar{E}\psi\psi^T$$

$$\text{CLT: } \frac{1}{\sqrt{N}} \sum e(t)\psi(t) \rightarrow N(0, \lambda\bar{E}\psi\psi^T)$$

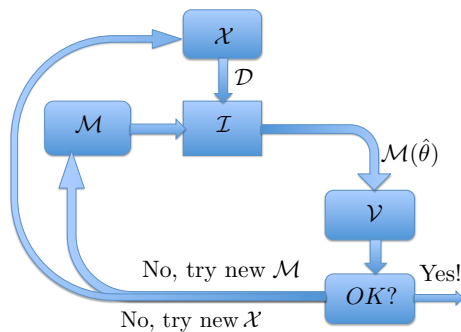
$$\sqrt{N}(\hat{\theta}_N - \theta^*) \rightarrow N(0, \lambda[\bar{E}\psi\psi^T]^{-1})$$

[ $\Phi_u, \Phi_v$ : Spectra of input and additive noise  $v = He$ .  $G_0$  true transfer function.]

$$\hat{\theta}_N \rightarrow \theta^* = \arg \min_{\theta} \int_{-\pi}^{\pi} |G(e^{i\omega}, \theta) - G_0(e^{i\omega})|^2 \frac{\Phi_u(\omega)}{|H(e^{i\omega}, \theta)|^2} d\omega$$

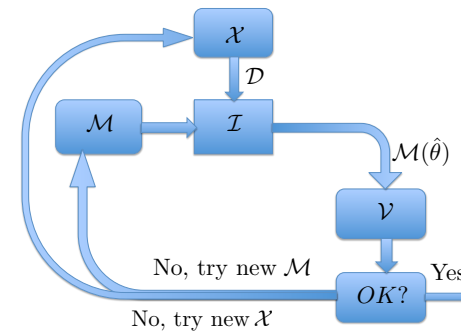
$$\text{Cov}G(e^{i\omega}, \hat{\theta}_N) \sim \frac{n \Phi_v(\omega)}{N \Phi_u(\omega)} \text{ as } n, N \rightarrow \infty \quad n : \text{model order}$$

Experiment Design:  $\mathcal{X}$



See Lecture Notes "Experiment Design"

Model Validation:  $\mathcal{V}$



“Twist and turn” the model(s) to check if they are good enough for the intended application.

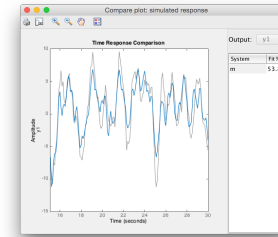
Essentially a subjective decision. Several basic techniques are available:

1. **Simulation (prediction) cross validation**
  - Check how well the estimated model can reproduce new, validation data
2. **Residual Analysis**
  - Are the "leftovers" unpredictable?
3. **Comparing Different Models**
  - Which one performs best?
4. **Bias-Variance Trade-off**
  - What is the suitable complexity (flexibility) of a model?



Collect a *estimation data set*  $Z_e$  and a *validation data set*  $Z_v$ .  
Estimate the model(s) using the estimation data and simulate it using the input signal in the validation data. Plot that simulated model output together with the measured validation output.

```
m = arx(z1(1:150), [2 2 1]);
compare(z1(151:end), m)
```

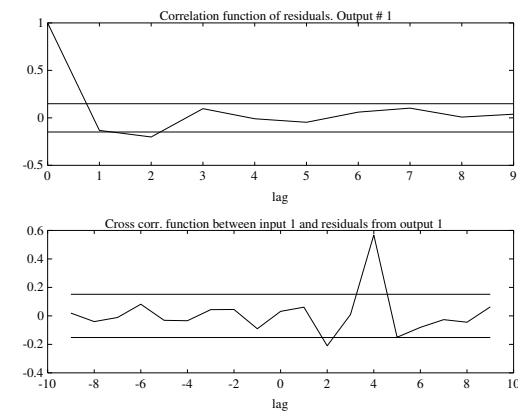


“The ultimate test”. Needs no probabilistic justification.  
Plot simulated outputs and measured outputs for the fresh data set. Alternatively one may use predictions over longer periods. Typically the performance can be evaluated as sum of squared mismatches. (“FIT”)



$$\varepsilon(t) = \varepsilon(t, \hat{\theta}_N) = y(t) - \hat{y}(t|\hat{\theta}_N)$$

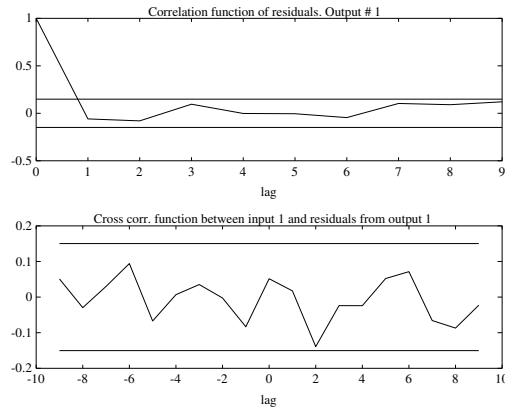
- $\varepsilon(t)$  should be independent of  $u(t - \tau), \tau > 0$
- $\varepsilon(t)$  should ideally be white noise.
- Compute the corresponding correlation functions
- Confidence intervals for the estimates can also be computed. This requires some care!



True delay: 4    guessed delay: 5







Guessed delay = true delay.

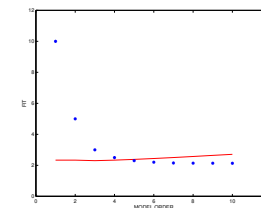
- What to compare?
  - simulation performance
  - prediction performance
- compare  $(z_v, t_h, k)$
- Comparing models on fresh data sets (Simulation cross validation as before)
- Comparing models on second-hand data sets

“Twist and turn” the model(s) to check if they are good enough for the intended application. Essentially a subjective decision. Several basic techniques are available:

1. Simulation (prediction) cross validation
  - Check how well the estimated model can reproduce new, validation data
2. Residual Analysis
  - Are the “leftovers” unpredictable?
3. Comparing Different Models
  - Which one performs best?
4. Bias-Variance Trade-off
  - What is the suitable complexity (flexibility) of a model?

Problem: Larger models will always perform better on estimation data.

BASIC IDEA: Compensate for over-fit



- Add Model Complexity Penalty
  - Akaike: AIC, FPE
  - Rissanen MDL
- Hypothesis test
  - Check if decrease in fit is larger than “expected”

AIC for Gaussian case:

$$\min_{\mathcal{M}} \min_{\theta_{\mathcal{M}}} \left[ \left(1 + \frac{2d_{\mathcal{M}}}{N}\right) \cdot \frac{1}{N} \sum_{t=1}^N \varepsilon^2(t, \theta_{\mathcal{M}}) \right], \quad d_{\mathcal{M}} = \dim \theta_{\mathcal{M}}$$

[ -log likelihood +  $d_{\mathcal{M}}$  ]

FPE similar, with  $(1 + \frac{2d_{\mathcal{M}}}{N})$  replaced by  $\frac{N+d_{\mathcal{M}}}{N-d_{\mathcal{M}}}$ . Aims at estimating the fit that would be obtained for a fresh data set.

MDL (or BIC) is like AIC but with a  $\frac{2d_{\mathcal{M}} \log N}{N}$  penalty.

- What to compare?
  - simulation performance
  - prediction performance
- compare (zv, th, k)
- Comparing models on fresh data sets (Simulation cross validation as before)
- Comparing models on second-hand data sets
- Comparing many models simultaneously

Any estimated model is incorrect. The errors have two sources:

- **Bias**: The model structure is not flexible enough to contain a correct description of the system.
- **Variance**: The disturbances on the measurements affect the model estimate, and cause variations when the experiment is repeated, even with the same input.

Mean Square Error (MSE) = |Bias|<sup>2</sup> + Variance.

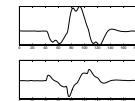
When model flexibility ↑, Bias ↓ and Variance ↑.

To minimize MSE is a good trade-off in flexibility.

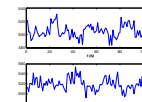
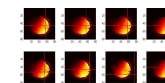
In state-of-the-art Identification, this flexibility trade-off is governed primarily by model order.

- Well established statistical theory
- Optimal asymptotic properties
- Efficient software
- Many applications in very diverse areas. Some examples:

- Aircraft Dynamics:



- Brain Activity (fMRI):



- Pulp Buffer Vessel:

